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O. F. F.
JUN 29 2005
PATENT AND TRADEMARK OFFICE

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

GRUNDY et al

Atty. Ref.: 3652-46

Serial No. 10/826,381

TC/A.U.: 2829

Filed: April 19, 2004

Examiner: Unassigned

For: SOFTWARE DESIGN SYSTEM AND METHOD

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June 29, 2005

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

INFORMATION DISCLOSURE STATEMENT

As suggested by 37 C.F.R. 1.97, the undersigned attorney brings to the attention of the Patent and Trademark Office the references listed on the attached form PTO-1449.

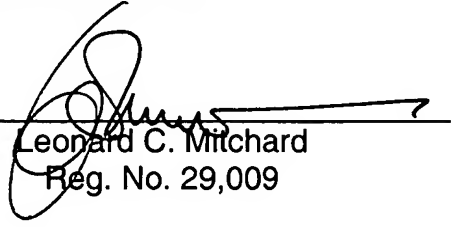
This is not to be construed as a representation that a search has been made or that no better prior art exists, or that a reference is relevant merely because cited.

The Examiner is requested to initial the attached form PTO-1449 and to return a copy of the initialed document to the undersigned as an indication that the attached references have been considered and made of record.

Respectfully submitted,

NIXON & VANDERHYE P.C.

By: _____


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INFORMATION DISCLOSURE
CITATION

ATTY. DOCKET NO.

SERIAL NO.

3652-46

10/826,381

APPLICANT

GRUNDY et al

FILING DATE

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April 19, 2004

2829

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

	Grundy, J.C., et al; "Generation of Distributed System Test-beds from High-level Software Architecture Descriptions"; In Proceedings of the 2001 IEEE Automated Software Engineering Conference, San Diego, 26-29 Nov. 2001; IEEE CS Press, pp. 193-200.
	Grundy, J.C., et al; "An Environment for Automated Performance Evaluation of J2EE and ASP.NET Thin-client Architectures"; In Proceedings of the 2004 Australian Software Engineering Conference, Melbourne, Australia, April 14-17, 2004, IEEE CS Press, pp. 300-308.

***Examiner**

Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.